ME 517: Micro- and Nanoscale Processes

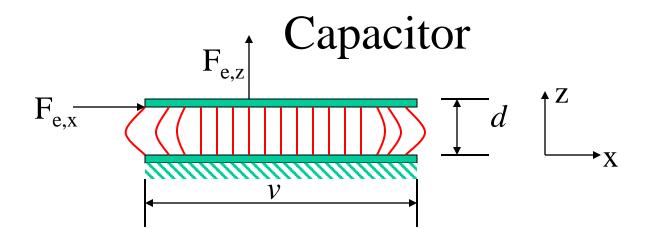
Lecture 14: Electrostatics II

Steven T. Wereley

Mechanical Engineering Purdue University West Lafayette, IN USA

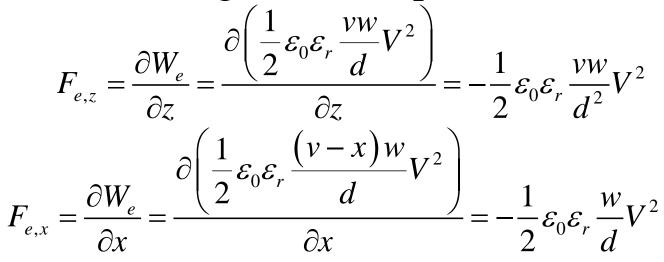
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Calculate force exerted on free plate by fixed plate

Force is the gradient of potential so



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Comparison of Actuators

Mechanical Transducers

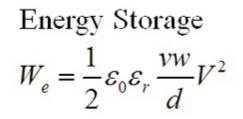
277 ←Kovacs

Type of Actuator	Stress (MPa)	Strain (%)	Strain Rate (Hz)	Power Density (W/kg)	Efficiency %
Electrostatic (macroscopic composite)	0.04	> 10	> 1	> 10	> 20
Cardiac Muscle (human)	0.1	> 40	4	> 100	> 35
Polymer (polyacrylic acid/polyvinyl alcohol)	0.3	> 40	0.1	> 5	30
Skeletal Muscle (human)	0.35	> 40	5	> 100	> 35
Polymer (polyaniline)	180	> 2	> 1	> 1,000	> 30
Piezoelectric Polymer (PVDF)	3	0.1	> 1	> 100	< 1
Piezoelectric Ceramic	35	0.09	> 10	> 1,000	> 30
Magnetostrictive (Terfenol-D)	70	0.2	1	> 1,000	< 30
Shape Memory Alloy (NiTi bulk fiber)	> 200	> 5	3	> 1,000	> 3

Table of linear actuator materials. After Hunter and Lafontaine (1992). The authors noted that the values provided did not always represent optimal materials, as development is active in many of these categories and that the power needed for accessory systems, such as cooling, were not included in the calculations.

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Electrostatics Scaling



Paschen breakdown voltage

curve from Madou

13, 16 µm

Breakdown Voltage V

1400

1200

1000 800

600 400 200

2.6 µm

Force Generation

$$F_{i,e} = \frac{\partial W_e}{\partial x_i} = -\varepsilon_0 \varepsilon_r \frac{w}{d} V^2$$

 $F \propto L^0$

Two modes of operation: •Constant voltage: V ∝L⁰

W_e∝L¹,

•Maximum voltage: V∝L¹

Constant Voltage:

P x d (Pressure x distance axis) at 1 atmosphere =(760 mm Hz

• Maximum Voltage: $W_e \propto L^3$, $F \propto L^2$

• Even bigger gains possible with very small gaps Micro/Nanoscale Physical Processes

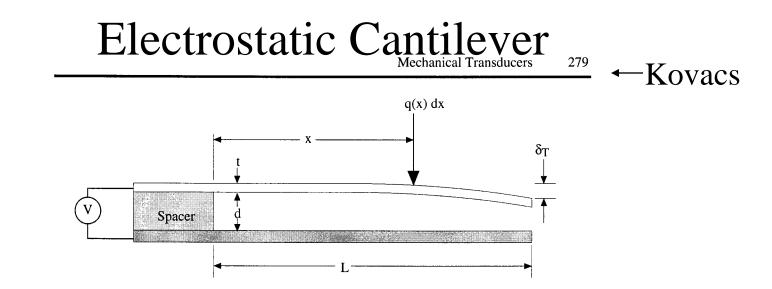


Illustration of an electrostatically deflected cantilever structure showing variable definitions for analysis. After Petersen (1978a).

- cantilever suspended above substrate forming parallel plate capacitor *in a vacuum*
- Analysis requires Euler-Bernoulli Beam Flexure Formula and electrostatics

Petersen, K.E., "Dynamic Micromechanics on Silicon: Techniques and Devices," IEEE Trans. On Electron Devices, vol. ED-25, no. 10, Oct. 1978, p. 1241-1250. Micro/Nanoscale Physical Processes

